# TOSHIBA

Q1:TOSHIBA FIELD EFFECT TRANSISTOR SILICON N CHANNEL MOS TYPE(U-MOSIII) Q2:TOSHIBA INCLUDES SCHOTTKY BARRIER DIODE FIELD EFFECT TRANSISTOR SILICON N CHANNEL MOS TYPE(U-MOSIII)

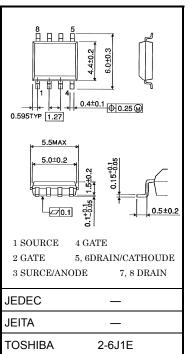
# TPC8A01

#### DC-DC CONVERTER Notebook PC Portable Machines and Tools

- Includes Schottky Barrier Diode Type. (Q2) Low Forward Voltage: V<sub>DSF</sub>=0.6V(Max.)
- Small footprint due to small and thin package.
- High Speed Switching.(Q1)
- Small Gate Charge.(Q1): Qg=17nC(Typ.)
- Low drain-source ON resistance(Q2)  $R_{DS}$  (ON) = 13 m $\Omega$  (typ.)
- High forward transfer admittance(Q2):  $|\,Y_{\rm fs}\,|$  = 11 S (typ.)
- Low leakage current. (Q1):  $I_{DSS} = 10 \ \mu A(Max.) (V_{DS} = 30 \ V)$
- - (Q1) V<sub>th</sub> = 1.1~2.3 V (V<sub>DS</sub> = 10 V, I<sub>D</sub> = 1 mA)
  - : (Q2)  $V_{th} = 1.1 \sim 2.3 \text{ V} (V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA})$

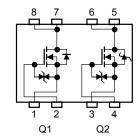
#### Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rat	Unit		
	0,111,001	Q1	Q2	0		
Drain-source v	V <sub>DSS</sub>	30	30	V		
Drain-gate vol	Drain-gate voltage ( $R_{GS} = 20 \text{ k}\Omega$ )			30	V	
Gate-source v	Gate-source voltage			±20	V	
Drain current	DC (Note 1)	ID	6	8.5	А	
Drain current	Pulse (Note 1)	IDP	24	34	A	
Drain power dissipation	Single-device operation (Note 3a)	P <sub>D(1)</sub>	P <sub>D(1)</sub> 1.5			
(t = 10s) (Note 2a)	Single-device value at dual operation (Note 3b)	P <sub>D(2)</sub>	1.1		w	
Drain power dissipation	Single-device operation (Note 3a)	P <sub>D(1)</sub>	0.75			
(t = 10s) (Note 2b)	Single-device value at dual operation (Note 3b)	P <sub>D(2)</sub>	0.45			
Single pulse avalanche energy		E <sub>AS</sub>	46.8 (Note 4a)	93.9 (Note 4b)	mJ	
Avalanche cur	IAR	6	8.5	А		
Repetitive avalanche energy Single-device value at operation (Note 2a, 3b, 5)		E <sub>AR</sub>	0.11		mJ	
Channel temp	Channel temperature		150		°C	
Storage tempe	T <sub>stg</sub>	-55~150		°C		



Weight: 0.080 g (typ.)

#### **Circuit Configuration**



(Includes Schottky Barrier Diode)

Note: (Note 1), (Note 2ab), (Note 3ab), (Note 4), (Note 5) Please see next page.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

This transistor is an electrostatic sensitive device. Please handle with caution.

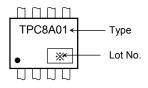
Schottky barrier diodes are having large-reverse-current-leakage characteristic compare to the other rectifier products. This current leakage and not proper operating temprature or voltage may cause thermalrun. Please take forward and reverse loss into consideration when you design.

Unit: mm

#### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit	
Thermal resistance, channel to ambient (t = 10s) (Note 2a)	Single-device operation (Note 3a)	R <sub>th (ch-a) (1)</sub>	83.3	
	Single-device value at dual operation (Note 3b)	R <sub>th (ch-a) (2)</sub>	114	°C/W
Thermal resistance, channel to ambient	Single-device operation (Note 2a)	R <sub>th (ch-a) (1)</sub>	167	C/W
Thermal resistance, channel to ambient (t = 10s) (Note 2b)	Single-device value at dual operation (Note 2b)	R <sub>th</sub> (ch-a) (2)	278	

#### Marking



Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2:

- a) Device mounted on a glass-epoxy board (a)
- b) Device mounted on a glass-epoxy board (b)



Note 3:

- a) The power dissipation and thermal resistance values are shown for a single device (During single-device operation, power is only applied to one device.).
- b) The power dissipation and thermal resistance values are shown for a single device (During dual operation, power is evenly applied to both devices.).

Note 4:

- a)  $V_{DD}$  = 24 V,  $T_{ch}$  = 25°C (Initial), L = 1.0 mH,  $R_G$  = 25  $\Omega,\,I_{AR}$  = 6.0 A
- b)  $V_{DD} = 24 \text{ V}, \text{ T}_{ch} = 25^{\circ}\text{C}$  (Initial), L = 1.0 mH, R<sub>G</sub> = 25  $\Omega$ , I<sub>AR</sub> = 8.5 A

Note 5: Repetitive rating; pulse width limited by max channel temperature.

- Note 6: on lower left of the marking indicates Pin 1.
  - ※ Weekly code: (Three digits)



Week of manufacture (01 for first week of year, continues up to 52 or 53)

Year of manufacture
 (One low-order digits of calendar year)

## Q1

## **Electrical Characteristics (Ta = 25°C)**

Cha	aracteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I <sub>GSS</sub>	$V_{GS}=\pm 16~V,~V_{DS}=0~V$	_		±10	μA
Drain cut-OFF current		I <sub>DSS</sub>	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-10	μA
Drain-source breakdown voltage		V (BR) DSS	$I_D=10\ mA,\ V_{GS}=0\ V$	30			v
		V (BR) DSX	$I_D=10\ mA,\ V_{GS}=-20\ V$	15		_	
Gate threshold vo	oltage	V <sub>th</sub>	$V_{DS}=10~V,~I_{D}=1~mA$	1.1	_	2.3	V
	resistance	Ppg (out)	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 3.0 \text{ A}$		23	30	
Drain-source ON resistance		R <sub>DS (ON)</sub>	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 3.0 \text{ A}$		18	25	mΩ
Forward transfer admittance		Y <sub>fs</sub>	$V_{DS}$ =10 V, $I_{D}$ = 3.0 A	4.5	9	_	S
Input capacitance		C <sub>iss</sub>		_	940		pF
Reverse transfer capacitance		C <sub>rss</sub>	$V_{DS}$ = 10 V, $V_{GS}$ = 0 V, f = 1 MHz	_	130		
Output capacitance		C <sub>oss</sub>		_	390		
Switching time	Rise time	tr	$V_{GS} \begin{array}{c} 10 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} I_D = 3.0 \text{ A} \\ 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} 0 \text{ V} \\ 0 \text{ V} \end{array} \right.$	_	17	_	ns
	Turn-ON time	t <sub>on</sub>		_	25	_	
	Fall time	t <sub>f</sub>			4	_	
Turn-OFF time to		toff	Duty $\leq$ 1%, t <sub>w</sub> = 10 µs		21	_	
Total gate charge (gate-source plus gate-drain)		0	$V_{DD}\simeq 24~V,~V_{GS}=10~V,I_D=6.0~A$		17	_	
		Qg	$V_{DD}\simeq 24~V,~V_{GS}=5~V, l_D=6.0~A$		10	_	nC
Gate-source charge 1		Q <sub>gs</sub> 1			1.9		ne
Gate-drain ("miller") charge		Q <sub>gd</sub>	$V_{DD}\simeq 24~V,~V_{GS}=10~V, I_D=6.0~A$		4.1		1
Gateswitch charge		Q <sub>sw</sub>			6		

#### Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I <sub>DRP</sub>	—	_	_	24	А
Forward voltage (diode)		VDSF	$I_{DR} = 6.0 \text{ A}, V_{GS} = 0 \text{ V}$		_	-1.2	V

## Q2 (Includes Schottky Barrier Diode)

## **Electrical Characteristics (Ta = 25°C)**

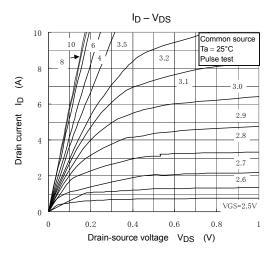
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I <sub>GSS</sub>	$V_{GS}=\pm 16~V,~V_{DS}=0~V$		—	±10	μA
Drain cut-OFF current		I <sub>DSS</sub>	$V_{DS}=30~V,~V_{GS}=0~V$	_	_	10	μA
Drain-source breakdown voltage		V (BR) DSS	$I_D=10\ mA,\ V_{GS}=0\ V$	30		_	V
		V (BR) DSX	$I_D=10~mA,~V_{GS}=-20~V$	15	—	—	
Gate threshold vo	oltage	V <sub>th</sub>	$V_{DS}=10 \ V, \ I_D=1 \ mA$	1.1	_	2.3	V
Drain-source ON	resistance	Pag (QL)	$V_{GS} = 4.5 \ V, \ I_D = 4.3 \ A$		16	21	- mΩ
	resistance	R <sub>DS (ON)</sub>	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 4.3 \text{ A}$		13	18	
Forward transfer admittance		Y <sub>fs</sub>	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 4.3 \text{ A}$	5.5	11	_	S
Input capacitance		C <sub>iss</sub>			2295	_	pF
Reverse transfer capacitance		C <sub>rss</sub>	$V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$		360	_	
Output capacitance		C <sub>oss</sub>		_	510	_	
Switching time	Rise time	tr	$V_{GS} \begin{array}{c} 10 \text{ V} \\ 0 \text{ V} \end{array} \begin{array}{c} I_D = 4.3 \text{ A} \\ \bullet \text{ V}_{OUT} \\ \hline \\ C \\ \bullet \text{ V}_{DD} \end{array} \begin{array}{c} 0 \text{ V}_{OUT} \\ \hline \\ R_L = \\ 3.5 \Omega \\ \hline \\ V_{DD} \simeq 15 \text{ V} \end{array}$		8	_	- ns
	Turn-ON time	t <sub>on</sub>			17		
	Fall time	t <sub>f</sub>		_	15	—	
	Turn-OFF time	t <sub>off</sub>	Duty $\leq$ 1%, t <sub>w</sub> = 10 $\mu$ s		52	_	
Total gate charge		0	$V_{DD}\simeq 24~V,~V_{GS}=10~V, I_D=8.5~A$	_	49	_	
(gate-source plus gate-drain)		Qg	$V_{DD}\simeq 24~V,~V_{GS}=5~V, I_D=8.5~A$	_	27		
Gate-source charge 1		Q <sub>gs</sub> 1		_	3.7		nC
Gate-drain ("miller") charge		Q <sub>gd</sub>	$V_{DD}\simeq 24~V,~V_{GS}=10~V,I_D=8.5~A$	_	10.8	—	
Gateswitch charge		Q <sub>sw</sub>	]	_	14.5	_	

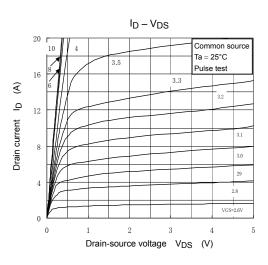
#### Source-Drain Ratings and Characteristics (Ta = 25°C)

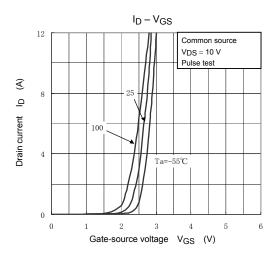
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I <sub>DRP</sub>	—	_		34	А
Forward voltage (diode)		V <sub>DSF</sub>	$I_{DR} = 1.0 \text{ A}, V_{GS} = 0 \text{ V}$	_	-0.5	-0.6	V
			$I_{DR} = 8.5 \text{ A}, V_{GS} = 0 \text{ V}$	—	_	-1.2	

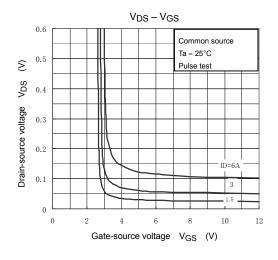
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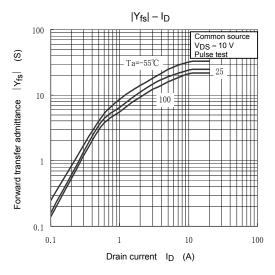
Q1



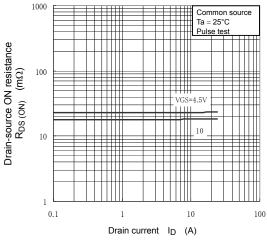








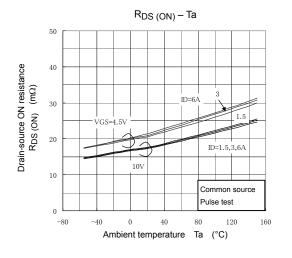
 $R_{DS(ON)} - I_D$ 

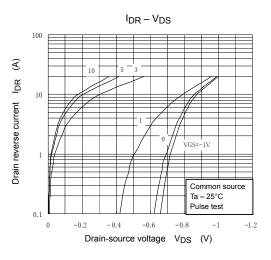


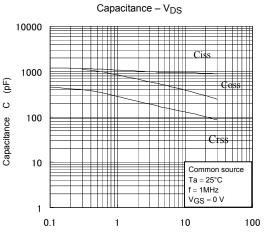
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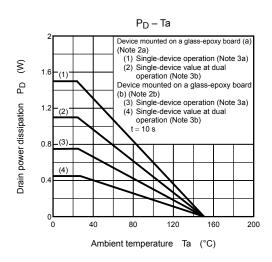
Q1

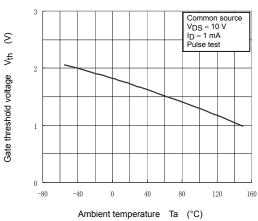




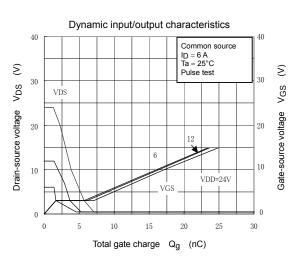








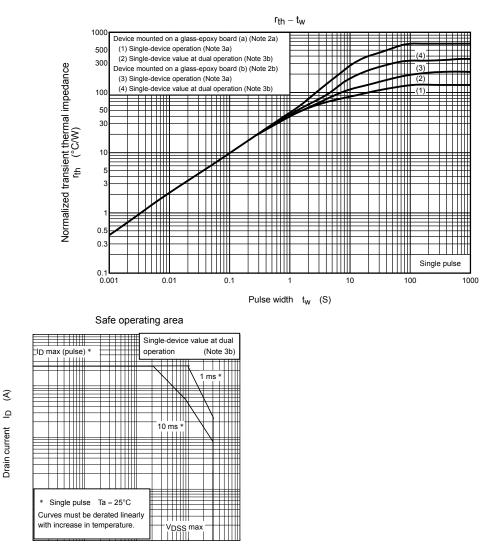
V<sub>th</sub> – Ta



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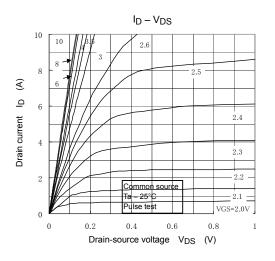
<u>TOSHIBA</u>

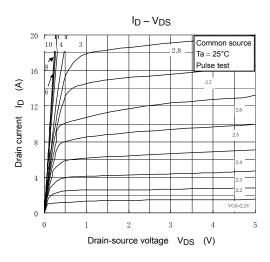
Q1

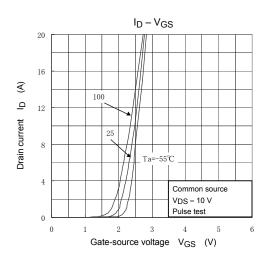


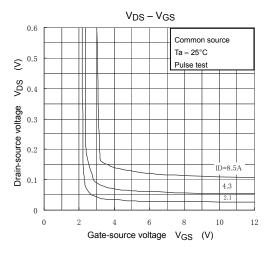
Drain-source voltage VDS (V)

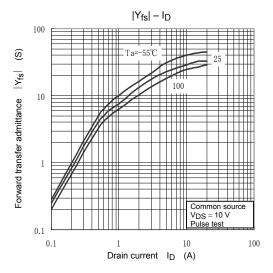
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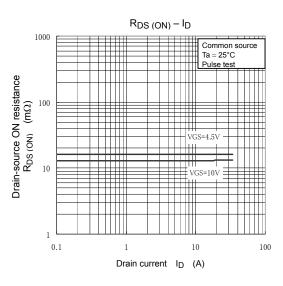




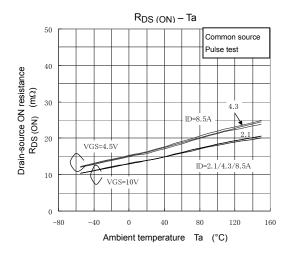


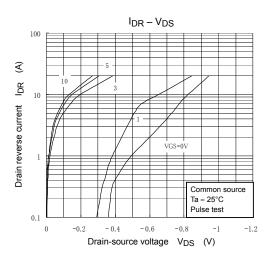


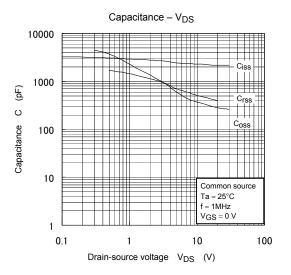


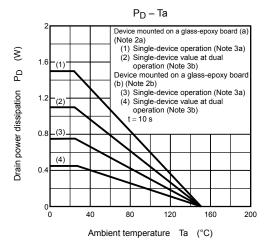


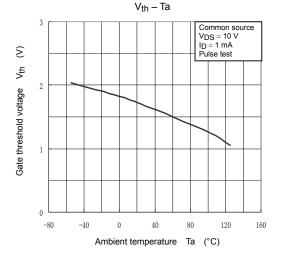
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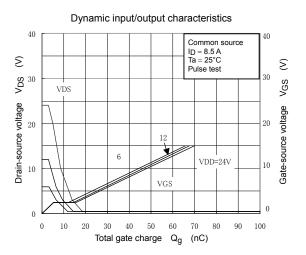




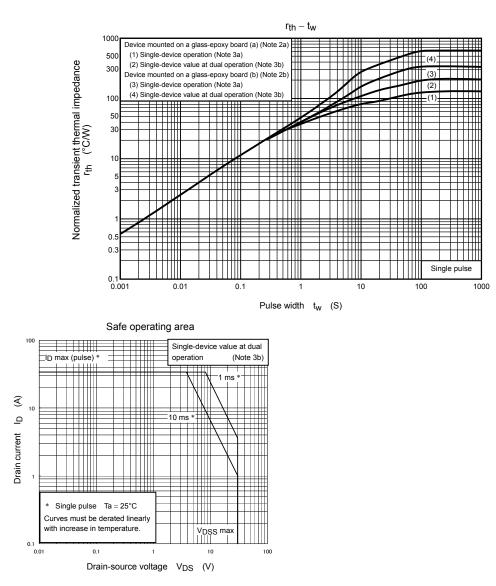








## Q2(Includes Schottky Barrier Diode)



# <u>TOSHIBA</u>

# Q2 (V<sub>GS</sub>=0V)

20 0

0

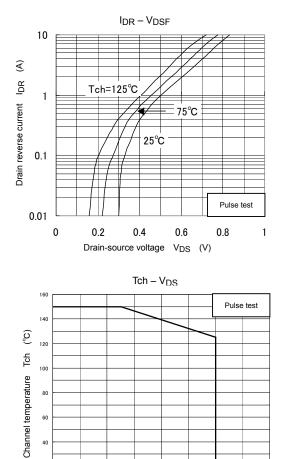
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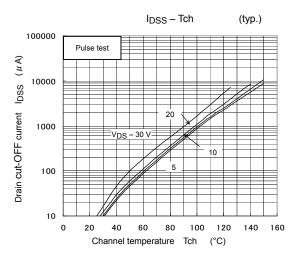
20

Drain-source voltage V<sub>DS</sub> (V)

30

40





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